

Notice of References Cited	Application/Control No. 10/667,245	Applicant(s)/Patent Under Reexamination COHEN, DEBORAH W.	
	Examiner Anthony Weier	Art Unit 1761	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,074,900	07-2006	Buchanan et al.	530/350
*	C	US-6,228,418	05-2001	Gluck et al.	426/623
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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